INTRODUCTION

This application note describes how to scan and detect button presses on more than 4 capacitive buttons. The target devices of this application note are the PIC16F616 family, PIC16F690 family and the PIC16F887 family of microcontrollers. It assumes knowledge of the general concept for capacitive sensing described in application note AN1101, “Introduction to Capacitive Sensing,” and it is recommended to have read AN1101 prior to this application note.

This application note will discuss three different approaches to implementing multiple touch buttons using Microchip microcontrollers. The first approach creates a simple 4 sensor system using the on-chip 4-to-1 analog multiplexers tied to the inputs of the comparator module. The second approach expands the 4 sensor system of the first approach, into a 10 sensor system by combining pairs of the original 4 inputs. The third approach creates an expandable system, which relies on multiplexing additional sensors through an external analog multiplexer.

USING DEFAULT CAPACITY

By default, PIC® microcontrollers with a comparator module capable of capacitive sensing*, may use the internal multiplexor to the comparator inputs to scan up to four buttons. The internal MUX is controlled by the channel select bits, C1CH<1:0> of CM1CON0 and C2CH<1:0> of CM2CON0. The channel must be set the same for both comparators.

A simplified block diagram from the data sheet for the PIC16F887 family is shown in Figure 1. It depicts the proper paths required for capacitive sensing as highlighted. The channel of select must be the same on each interal multiplexer. So, when switching buttons from one to the next, ensure that they are the same. They must be the same because the basic sensing oscillator circuit requires the voltage on the capacitor to be compared to the upper and lower limit C1IN+ and C2IN+. If the negative inputs were different, the circuit would not oscillate and would be stuck either high or low.

FIGURE 1: COMPARATOR C1 SIMPLIFIED BLOCK DIAGRAM

* Comparator modules capable of touch sense as described must have the SR-latch option.
To handle scanning four buttons is straightforward in software when using C code. It is easiest to handle the buttons’ measured raw and average data as arrays, where each entry is a button’s value. It is also nice to have individual trip thresholds for each button, in the event different buttons behave differently. In plain C, these variables would be declared as follows:

```c
unsigned int average[4];
unsigned int trip[4];
```

The array variable average holds the average values for each button, indexed 0 to 3. Likewise, the most recent reading may be stored in an array for viewing or to aid design, but this raw data does not need to be stored since it is measured at the end of a scan when a decision for pressed or not pressed is made in the Interrupt Service Routine (ISR).

To set the big picture before going into further detail, the basic operation is completed in the Interrupt Service Routine. The ISR will be called by a Timer0 overflow interrupt each time a button is ready to have a measurement taken and complete a scan. It may be called due to other interrupts, and those should be handled appropriately by the user, to coexist with the fixed time-base Timer0 interrupts. An abstracted, high level form is as follows:

**EXAMPLE 1: SIMPLE ISR**

```c
void isr {
  // If capacitive interrupt
  if (T0IF == 1) {
    // Grab TMR1 Reading
    StopTimers();
    GetMeasurement();

    // Test if Pressed
    if (IsButtonPressed(index))
      SetFlag(index);
    else
      ClearFlag(index);

    // Perform 16-point average
    PerformAverage(index);

    // Set next sensor
    index = (++index) & 0x03;
    SetComparators(index);
    RestartTimers();
  }
}
```
Handling multiple buttons entails writing the portion below the comment “Set next sensor”. To advance through the four buttons, an index variable will be needed to keep track of which button is being scanned and to initiate proper settings based on that index. Using four buttons, the index will go from 0 to 3, just like the array of average and trip values. This variable will be declared as such:

```c
unsigned char index;
```

At the end of the ISR, the index variable will increment on each scan to prepare for the next scan. After incrementing the index variable, the comparator channel select bits, C1CH<1:0> and C2CH<1:0>, must be set and Timer0 and Timer1 must be restarted. This may be done many ways, but a convenient way is to create an array of 4 constants with the settings for the entire registers, CM1CON0 and CM2CON0, and then use the index to grab the indexed value and load the registers.

For example, assume the constant arrays are declared as COMP1 and COMP2. The values come from the necessary settings for the register, and then changing the channel bits, bit 0 and bit 1 of each.

```c
COMP1 = {0x94, 0x95, 0x96, 0x97}
COMP2 = {0xA0, 0xA1, 0xA2, 0xA3}
```

After index change (at end of ISR):

```c
EXAMPLE 2: SETTING COMPARATORS

void SetComparators(char index) {
    CM1CON0 = COMP1[index];
    CM2CON0 = COMP2[index];
}
```

Each pass, the ISR will perform its scan, increment index, and then prepare for the next button to scan, as done by setting the CMxCON0 registers and restarting the timers. The index must only increment to 3 and it must wrap-around from 3 back to 0, but this is a software detail that is easy to handle. One way to count to three and wrap-around is to AND the result with 3, which will clear the uppermost 6 bits, as done in Example 1 above. The variable index increments to 4 (0b100), and then an AND operation with 3 (0b011) makes the result 0.

Now, four buttons are scanned sequentially 0, 1, 2, 3, 0, 1, 2, 3 ... over and over, and the remaining portions to complete are the SetFlag(int index), ClearFlag(int index) and PerformAverage(int index) functions. Setting and clearing flags may suffice for some applications, other applications may directly take an action. Base the action of a button on its index, because the index is used to indicate which button is pressed. The same is true for the running 16 point average. The average should be recalculated each pass, and it should be stored in the appropriate index of the average array.

EXPANDING BY PAIRED PRESS

One of the major drawbacks to using the comparator module for a touch button interface is its limited number of inputs. One way to add support for additional sensors is to create new touch sensors that combine pairs of existing touch inputs (see Figure 3). When a combined pair sensor is touched by the user, both of the shared sensor inputs are affected equally and the software differentiates the touch from a single input by the reduce shift and the affect on two inputs instead of just one.

FIGURE 3: MULTIPLE BUTTONS WITH ONLY 4 INPUTS

Because the paired sensor inputs combine existing inputs, no additional circuitry is required and the memory overhead for the averaging system is not increased. The only additional requirement on the decoding logic is the need to search for both single and paired press conditions.

Table 1 lists the number of touch sensors that can be generated, given a fixed number of sensor inputs. Since the comparator input has an internal MUX with four channels, the maximum number of sensors is ten.

<table>
<thead>
<tr>
<th>Number of inputs</th>
<th>Number of sensors</th>
</tr>
</thead>
<tbody>
<tr>
<td>2</td>
<td>3</td>
</tr>
<tr>
<td>3</td>
<td>6</td>
</tr>
<tr>
<td>4</td>
<td>10</td>
</tr>
<tr>
<td>5</td>
<td>15</td>
</tr>
<tr>
<td>6</td>
<td>21</td>
</tr>
<tr>
<td>7</td>
<td>28</td>
</tr>
<tr>
<td>N</td>
<td>0.5 (N^2 + N)</td>
</tr>
</tbody>
</table>

TABLE 1: MAXIMUM NUMBER OF SENSORS
Using the paired sensor system does have limitations. Only one sensor can be pressed at a time and the paired sensors will only shift the frequency of the sensor circuit half as far as full sensors. This will require some additional logic in the decoding routines, and can limit the sensitivity of some sensor inputs. The designer should take this into consideration when laying out the system, placing full sensors in applications requiring greater sensitivity, and placing paired sensors in applications that can tolerate less sensitivity.

The sensor pattern for a paired sensor requires the interleaving of the two sensor inputs (see Figure 4).

**FIGURE 4: SINGLE VERSUS PAIRED SENSOR PAD DESIGN**

- Single Sensor Element
- Paired Sensor Element

The interleaving of the sensors is required to keep the shift of both inputs as equal as possible, given the uncertainty of finger placement on the sensor. If possible, the areas of the two sensor elements should be equal, and approximately the size of ½ a single sensor. While this does increase the size of the sensor, it allows for more sensitivity on the paired sensor. Note the spacing between the two elements of a paired sensor should also be as large as possible to prevent interaction between the elements when the single sensors attached to each side are activated.

The decode logic for a shared button system starts by testing each frequency value against two touch thresholds, one for single sensor operation, and a smaller threshold for paired operation. The results of these tests are then passed through a search algorithm which checks for paired shifts, first, and then single shifts. If a paired shift is discovered, the button is considered detected and the single shift test is skipped. If a paired shift is not detected, then the single shift test is performed and any press conditions detected are reported. If more than two shifts beyond the paired threshold are detected, then a Fault condition is asserted and the decoding routine is terminated.

**EXPANDING BY MULTIPLEXERS**

Another option to expand the capacity for buttons is to use an external MUX, or several external MUXes. This is a very effective approach to handling very large numbers of buttons; it does not use any special tricks as does the ‘paired-press’ technique. However, it does come at the expense of more PCB surface area, and each MUX introduces capacitance which reduces sensitivity. System-wide scan rate also slows as buttons are added. So, it is recommended to start with 1 MUX per comparator input channel, and then build and test progressively with each additional MUX. Chaining an unlimited number of MUXes together is prevented by increasing parasitic capacitance, because eventually, too much parasitic capacitance will make the additional change in capacitance from a finger press undetectable.

Handling an external MUX is much like handling the internal MUX to select which comparator input channel should be routed to the two comparators. Now, additional select channels which select the MUX line are external to the part, and so I/O pins must select the channel with the capacitive pad that the MUX connects, and internally the comparator input channel select bits must determine the appropriate channel to ensure a connection from the MUX’s common line to the correct comparator input.

The schematic in Figure 5 shows how to connect external MUXes to a PIC microcontroller. The basic schematic is the same as in AN1101, “Introduction to Capacitive Sensing,” but a pad passes through the MUX to its common line before connecting to the comparator inputs.

**Note:** A suggested 8-channel analog MUX is a 74HC4051, and a 16-channel MUX, the 74HC4067.

Now, it is crucial to pay attention to how the indices of the buttons are assigned on both the MUX the button is on, and what comparator input channel that MUX’s common line is tied to. The index is the variable described earlier to identify the appropriate button to scan and to cycle through all the buttons. A logical way to set up the button index values is as follows. Consider 32 buttons to be desired, 4 8-channel MUXes are required. On C12IN0 -, place MUX0; this multiplexer will hold buttons 0 through 7. On C12IN1 -, place MUX1 for buttons 8 through 15. On C12IN2 -, place MUX2 for buttons 16-23, and likewise place MUX3 on C12IN3 - for button indices 24-31.

The software to handle such a setup then is fairly simple to handle. If the index is 0-7, enable MUX0 and set the channel select bits to the index value \( \epsilon \{ 0, 7 \} \). If the index is greater than 7, the modulus of the index by 8 yields the channel select bits, and the MUX to enable is given by the integer division of index by 8. For example, assume that index \( = 21 \):

- \( \text{index} \mod 8 = 21 \mod 8 = 5 \)
- \( \text{index} / 8 = 21 / 8 = 2 \)

MUX channel select bits \( = 5 = (101)_2 \)

MUX to enable \( = 2 = \text{MUX2} \)

To verify this is correct, look back at how the button indices were assigned. On C12IN2-, MUX2 holds buttons 16-23, and on that MUX the channel for 21 is the 6th channel (whose index is 5).
In addition to enabling the external MUX and its control lines, the appropriate comparator input must be selected for the internal 4-channel MUX. Because of the definition of MUXx on C12INx- chosen before, the integer division index/8, conveniently also yields the comparator input channel bits to select for C1CH and C2CH. The following code example shows how to scan 32 buttons as in the described configuration.
EXAMPLE 3: CODE EXAMPLE

```c
void isr {
    // If capacitive interrupt
    if (T0IF == 1) {
        // Grab TMR1 Reading
        StopTimers();
        GetMeasurement();

        // Test if Pressed
        if (IsButtonPressed(index))
            SetFlag(index);
        else
            ClearFlag(index);

        // Perform 16-point average
        PerformAverage(index);

        // Set next sensor
        // *** DIFFERENT THAN PREVIOUS ***

        // Increment index, wrap to 0
        if (index < 31)
            index++;
        else
            index = 0;

        div = index / 8;
        rem = index % 8;

        // Enable Correct MUX
        // (Assumes MUX EN active
        // low lines on RB<7:4>)
        switch(div) {
            // Enable MUX 0, 1, 2, or 3
            // Disable all, then set correct mux
            // enabled, active low
            case 0: PORTB |= 0xF0; RB4=0; break;
            case 1: PORTB |= 0xF0; RB5=0; break;
            case 2: PORTB |= 0xF0; RB6=0; break;
            case 3: PORTB |= 0xF0; RB7=0; break;
            default: break;
        }

        // Set MUX Channel
        // (Assumes channel lines = RB<2:0>)
        PORTB &= 0xF8; // Clear <2:0>
        PORTB |= rem; // Set 3 LSb's

        // SetComparators
        CM1CON0 = COMP1[div];
        CM2CON0 = COMP2[div];
    }
    RestartTimers();
}
```

COMPARISONS

Each method to handle buttons has its own benefits and downsides. A table comparing some key traits of each method is below.

<table>
<thead>
<tr>
<th>Method</th>
<th>Max Buttons</th>
<th>2 Buttons At Once</th>
<th>Scan Rate</th>
<th>I/O Lines</th>
</tr>
</thead>
<tbody>
<tr>
<td>Stock</td>
<td>4</td>
<td>YES</td>
<td>++</td>
<td>+</td>
</tr>
<tr>
<td>Paired Press</td>
<td>10</td>
<td>NO</td>
<td>+</td>
<td>+</td>
</tr>
<tr>
<td>Multiplexed</td>
<td>N*</td>
<td>YES</td>
<td>-</td>
<td>-</td>
</tr>
</tbody>
</table>

* Number of buttons may not be arbitrarily increased forever due to physical limitation of detection.

Completely stock use is great for applications requiring 4 buttons or less. Often applications requiring only 1 or 2 buttons will best be suited by using this hardware setup. It has the fastest scan rate potential and better distance sensing capability compared to MUXed inputs due to less parasitic capacitance.

Using a paired press technique is economical, when at most, 10 buttons are required and no two buttons need to be pressed simultaneously. Using paired presses requires no additional external parts, aside from extra traces and button pads. This simple hardware expansion requires more complex software.

Multiplexed button systems’ largest benefits are the ability to have more than 10 buttons. It also allows that two buttons may be pressed simultaneously. However, the scan rate is tied to the number of inputs to be scanned. As the number of buttons increases, so will the scan rate, as an extreme number of buttons may become limiting. Changing Timer0’s prescaler will speed up or slow down the scan rate, and may provide relief to long scan rates, but is also influential in the sensing process itself. With more and more MUXes, parasitic capacitance will eventually grow too large to detect a press, as described in the “Expanding by Multiplexers” section. So, there are several things preventing arbitrary increase of the number of buttons, but the number of capable buttons is easily greater than the stock or paired press techniques.
CONCLUSION

Controlling many capacitive buttons can be handled in a number of ways. The PIC16F616 family, PIC16F690 family and the PIC16F887 family all contain the capability for four buttons inherently, expandable to 10 buttons without external parts. For additional button capacity, external MUXes may be used.

The key sensing method is the same in the capacitive Interrupt Service Routine, but handling many buttons requires keeping track of which index represents which physical button correctly. Planning the software index to physical button relationship during the physical design process will help make the software portion of design easier to implement, write and read.

Other application notes of interest are AN1101 “Introduction to Capacitive Sensing”, AN1102, “Layout And Physical Design Guidelines for Capacitive Sensing”, and AN1103 “Software Handling for Capacitive Sensing”. 
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